Notice of References Cited	Application/Control No. 10/598,160	Applicant(s)/Patent Under Reexamination OKA ET AL.		
	Examiner	Art Unit	Page 1 of 1	
	YOSHITOSHI TAKEUCHI	1793		

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-3,779,817	12-1973	Brunko, Wade D.	148/593
	В	US-			
	O	US-			
	ם	US-			
	Е	US-			
	F	US-			
	G	US-			
	Ι	US-			
	-	US-			
	٦	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	JP 2000017325	01-2000	JP	Tsukagoshi et al	C21D001/00
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.